## Application/Control No. Applicant(s)/Patent Under Reexamination 10/082,160 TAKAHASHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2818 Thao P Le **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY US-6597929 455/574 07-2003 Han et al. US-В US-С US-D Ε US-F US-US-G US-Н 1 US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Τ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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